Product Specification
108-60028
AMP Mini CT Hybrid Lattice Connector, 1.5mm Pitch
Lead Free Version

1. Scope:

1.1 Contents:

This specification covers the requirements for product performance, test methods and quality assurance provisions of AMP Mini CT Hybrid Lattice Connector, 1.5mm Pitch, Lead Free Version. Applicable product description and part numbers are as shown in Fig.1.

Product Part No.	Description
x-292248-x x-292249-x	Plug Assembly Kit, 1.5mm Pitch Mini CT Hybrid Lattice Connector, Lead Free
x-292245-x	Plug Assembly, 1.5mm Pitch Mini CT Hybrid Lattice Drawer Connector Lead Free
x-292247-x	Receptacle Assembly Kit, 1.5mm Pitch Mini CT Hybrid Lattice Connector, Lead Free
x-292246-x	Receptacle Assembly, 1.5mm Pitch Mini CT Hybrid Lattice Connector, Lead Free
1123907-1	Power Receptacle Contact, Hybrid Lattice Connector
1123910-1	Power Tab Contact Hybrid Lattice Connector
x-1123913-x x-1123914-x x-1318655-x x-1318656-x	Plug Covers, 1.5mm Pitch Mini CT Hybrid Lattice Connector
x-1123919-x x-1318452-x	Dust Cover, 1.5mm Pitch Mini CT Hybrid Lattice Connector

Fig. 1

2. Applicable Documents

The following documents form a part of this specification to the extent specified herein. In the event of conflict between the requirements this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements this specification and referenced documents, this specification shall take precedence.

2.1 AMP Specifications:

A. 109-5000 Test Specification, General Requirements for Test Methods

B. 114-5256 Application Specification

C. 501-51022 Qualification Test Report

2.2 Commercial Standards and Specifications:

A. MIL-STD-202: Test Methods for Electronic and Electrical Component Parts.

B. IEC: International Electrotechnical Comission

3. Requirements:

3.1 Design and Construction:

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

3.2 Materials:

3.2.1 Plug Assembly

A. Signal Contact

Material:	Phosphor Brozne
Finish (Mini CT post area):	Tin plating over Nickel underplating
Finish (Drawer mating area):	i) Gold plating over Nickel underplating, or
	ii) Gold over Palladium-Nickel over Nickel underplating

B. Power Contact

Material:	Phosphor Bronze
Finish:	Pre-plated Tin

C. Housing

Material:	Glass-filled PBT UL94V-0

3.2.2 Receptacle Assembly

A. Signal Contact

Material:	Brass
Finish (Mini CT post area):	Tin plating over Nickel underplating
Finish (Drawer mating area):	i) Gold plating over Nickel underplating
	ii) Gold over Palladium-Nickel over Nickel underplating

B. Power Contact

Material:	Phosphor Bronze
Finish:	Pre-plated Tin

C. Housing

Material:	Glass-filled PBT UL94V-0

3.2.3 Accessories & Hardware

A.	Dust Cover:	Nylon 6/6, UL94V-0
B.	Cable Clamp:	Cold Rolled Steel, Nickel over copper underplating
C.	Plug Covers:	ABS/PC Polymer Alloy, UL94V-HB
D.	Screws:	Steel, Nickel over copper underplating

3.3 Ratings:

A.	Voltage Rating (Signal):	50 V(AC/DC)
	Voltage Rating (Power):	250 VAC
B.	Current Rating (Signal):	1A Max
	Current Rating (Power):	AWG #16: 7 A
		AWG #18: 6 A
		AWG #20: 5 A
C.	Temperature Rating:	-30℃ to +105℃

The upper limit of the temperature includes the temperature rising resulted by the energized electrical current.

3.4 Performance Requirements and Test Descriptions:

The product shall be designed to meet the electrical, mechanical and environmental performance requirements specified in Fig.2. All tests shall be performed in the room temperature unless otherwise specified.

3.5 Test Requirements and Procedures Summary:

Para.	Test Items	Requirements	Procedures
3.5.1	Examination of product	Product shall be confirming to the requirements of applicable product drawing and applicable Specification	Visually, dimensionally and functionally inspected per applicable quality inspection plan
Electrical Requirements			
3.5.2	Termination Resistance (Low Level)	Signal Line: 30 mΩ Max. (Initial) 40 mΩ Max. (Final) Power Line: 10 mΩ Max. (Initial) 20 mΩ Max. (Final)	Subject mated connectors to 20 mV Max open circuit at 10 mA Refer Fig. 4
3.5.3	Dielectric withstanding voltage	No creeping discharge or flashover shall occur. Current leakage: 5mA Max.	Signal Line: 500 VAC for 1 minute. Power Line: 2.2 kVAC for 1 minute. Test between adjacent circuits of mated connectors. MIL STD 202 TEST Method 301 IEC 512-2 TEST 4A
3.5.4	Insulation Resistance	500 MΩ Min. (Initial) 100 MΩ Min. (Final)	Impressed voltage 500VDC for 1 minute. Test between adjacent circuits of mated connectors. MIL STD 202 TEST Method 302 Condition B
3.5.5	Temperature Rising vs. Current	30°C Max. under loaded rating current	Contacts series-wired, apply test current of loaded rating current to the circuit, and measure the temperature rising by probing on soldered areas of contacts, after the temperature becomes stabilized deduct ambient temperature from the measured value

Fig.2. To be continued

<table>
<tr><th>Para.</th><th>Test items</th><th colspan="5">Requirements</th><th>Procedures</th></tr>
<tr><td colspan="8">Mechanical Requirements</td></tr>
<tr><td rowspan="5">3.5.6</td><td rowspan="5">Crimp Tensile Strength (Power contacts only)</td><td colspan="2">Wire Size</td><td colspan="3">Crimp Tensile (Min.)</td><td rowspan="5">Apply an axial pull-off load to a crimp wire, with the contact secured to the tester.
Operation Speed: 100 mm/min.</td></tr>
<tr><td>mm^2</td><td>AWG</td><td colspan="2">N</td><td>kgf</td></tr>
<tr><td>0.51</td><td>#20</td><td colspan="2">58.8</td><td>6</td></tr>
<tr><td>0.87</td><td>#18</td><td colspan="2">68.6</td><td>7</td></tr>
<tr><td>1.27</td><td>#16</td><td colspan="2">78.4</td><td>8</td></tr>
<tr><td>3.5.7</td><td>Contact-housing Insertion Force (Power contacts only)</td><td colspan="5">9.8 N (1.0 kgf) Max. per contact</td><td>Measure force required to insert contact into housing</td></tr>
<tr><td rowspan="2">3.5.8</td><td rowspan="2">Contact Mating/Unmating Force (Power Receptacle contacts only)</td><td colspan="3">Mating Force (Max.)</td><td colspan="2">Unmating Force(Min.)</td><td rowspan="2">Measure using gage tab (Fig. 6) with operational speed of 100 mm/min.</td></tr>
<tr><td colspan="3">6.86N (0.7kgf) (Initial ~ 25th cycles)</td><td colspan="2">0.34N(35gf) (Initial)
0.25N (25gf) (25th cycles)</td></tr>
<tr><td>3.5.9</td><td>Contact Retention Force</td><td colspan="5">Signal Contact:
14.7N (1.5 kgf) Min. in direction of mating with Mini CT Receptacle.
Power Contact:
41.2 N (4.2 kgf) Min.</td><td>Measure contact retention force.
Operation Speed: 100 mm/min.</td></tr>
<tr><td rowspan="3">3.5.10</td><td rowspan="3">Connector Mating/Unmating Force</td><td>Pos. size (Power /Signal)</td><td colspan="2">Mating Force (Max.)</td><td colspan="2">Unmating Force (Min.)</td><td rowspan="3">Operation Speed: 100 mm/min.
Measure the force required to mate and unmate connectors.
Housing lock is not to be included.</td></tr>
<tr><td>4/14</td><td colspan="2">41.2 N (4.2 kgf)</td><td colspan="2">7.2 N (0.74 kgf)</td></tr>
<tr><td>4/22</td><td colspan="2">49 N (5.0 kgf)</td><td colspan="2">8 N (0.82 kgf)</td></tr>
<tr><td>3.5.11</td><td>Panel Retention Force</td><td colspan="5">156.8 N (16 kgf) Min.</td><td>Measure panel retention force using panel of nominal cut-out dimension as specified in the AMP Customer Drawing. Loading is made from the direction opposite to connector insertion direction.</td></tr>
<tr><td>3.5.12</td><td>Housing Lock Strength</td><td colspan="5">98N (10kgf) Min.</td><td>Measure connector locking strength.
Operational speed: 100 mm/min</td></tr>
<tr><td>3.5.13</td><td>Safety Test – exposure of contacts to test finger. (Receptacle Assembly only)</td><td colspan="5">No electrical conductivity between test finger and contacts in housing</td><td>Insert test finger (dimensions per Fig. 19 of IEC-950) into Receptacle Assembly.
Check for electrical conductivity between test finger and contacts.</td></tr>
</table>

Fig. 2 (To be continued)

Para.	Test Items	Requirements	Procedures
3.5.14	Cable Retention Force (Axial Direction)	98 N (10 kgf) Min.	Measure cable retention force in axial direction. Operational Speed: 100 mm/min.
3.5.15	Durability (Repeated Mating & Unmating)	Signal Line: 40 mMax. (Final) Power Line: 20 mMax. (Final))	Operation Speed: 100 mm/min. No of Cycles: 25 cycles.
3.5.16	Vibration (Low Frequency)	No electrical discontinuity greater than 1 μ sec. Shall occur. Signal Line 40 mΩ Max. (Final) Power Line: 20 mΩ Max. (Final)	Subject mated connectors to 10-55-10 Hz traversed in 1 minute at 1.52mm amplitude 2 hours each of 3 mutually perpendicular planes. MIL-STD-202 TEST Method 201 Condition A Mounting: Fig. 5
3.5.17	Physical Shock	No electrical discontinuity greater than 1 μ sec. Shall occur. Signal Line: 40 mΩ Max. (Final) Power Line: 20 mΩ Max. (Final)	Accelerated Velocity: 490 m/s^2 (50G) Waveform: halfsine shock pulse Duration: 11 m sec Number of shocks: 3 shocks in each direction applied along the X, Y and Z axes, totally 18 shocks. MIL-STD-202 TEST Method 213 Condition A IEC 68-2-27, Test Ea Mounting: Fig. 5
3.5.18	Hammering Shocks	No electrical discontinuity greater than 1 μ sec. Shall occur. Signal Line: 40 mΩ Max. (Final) Power Line: 20 mΩ Max. (Final)	Subject mated connectors to 10,000 cycles of hammering shocks in set up as shown in Fig. 6, with test current of 1 mA at DC 10V applied to circuits as shown in Fig. 7 During the test, the circuit shall be monitored for fluctuation of electrical resistance.

Fig. 2 (To be continued)

Para.	Test Items	Requirements	Procedures
Environmental Requirements			
3.5.19	Thermal Shock	Signal Line: 40 mΩ Max. (Final) Power Line: 20 mΩ Max. (Final)	Subject mated connectors to -55 °C/30min., +85 °C/30min. This being 1 cycle repeat for a total of 25 cycles. MIL-STD-202 TEST Method 107
3.5.20	Humidity-Temperature Cycling	Insulation resistance 100 MΩ Min. (Final) Termination resistance Signal Line: 40 mΩ Max. (Final) Power Line: 20 mΩ Max. (Final)	Subject mated connector to 25-65°C, 90-95 %R.H., 10 cycles. With cold shock –10 °C. Re-condition in room temperature for 3hrs before subsequent measurement. MIL-STD-202 TEST Method 106 IEC 68-2-38, Test Db.
3.5.21	Salt Spray	Signal Line: 40 mΩ Max. (Final) Power Line: 20 mΩ Max. (Final)	Subject mated connectors to 5±1% salt concentration for 48 hours. After test, rinse the samples with water and recondition the room temperature for 1 hour before subsequent measurements MIL-STD-202 TEST Method 101, Condition B. IEC 68-2-11, Test Ka.
3.5.22	Temperature Life (Heat Aging)	Signal Line: 40 mΩ Max. (Final) Power Line: 20 mΩ Max. (Final)	Subject mated connector to 85±2°C, 500 hours. MIL-STD-202 TEST Method 108.

Fig. 2 (End)

4. Product Qualification Test Sequence

Test of Examination	Test Group																
	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17
	Test Sequence(a)																
Examination of Product	1,4,8	1,3	1,3	1,3	1,3	1,3	1,3	1,3	1,3	1,3	1,5	1,6	1,5	1,5	1,5	1,5	1,5
Termination Resistance (Low Level)	2, 5										2,5	2,4	2,4	2,4	2,4	2,4	2,4
Dielectric withstanding voltage	7																
Insulation Resistance	6																
Temperature Rising vs. Current		2															
Crimp Tensile Strength			2														
Contact-housing Insertion Force				2													
Contact Mating/Unmating Force					2												
Contact Retention Force						2											
Connector Mating/Unmating Force							2										
Panel Retention Force								2									
Housing Lock Strength									2								
Safety Test – Test Finger											3						
Cable Retention Force										2							
Durability Cycling											4						
Vibration (Low Frequency)												3					
Physical Shock													3				
Hammering Shocks														3			
Thermal Shock															3		
Humidity-Temperature Cycling	3																
Salt Spray																3	
Temperature Life (Heat Aging)																	3

(a) Numbers indicated sequence in which tests are performed.

Fig.3

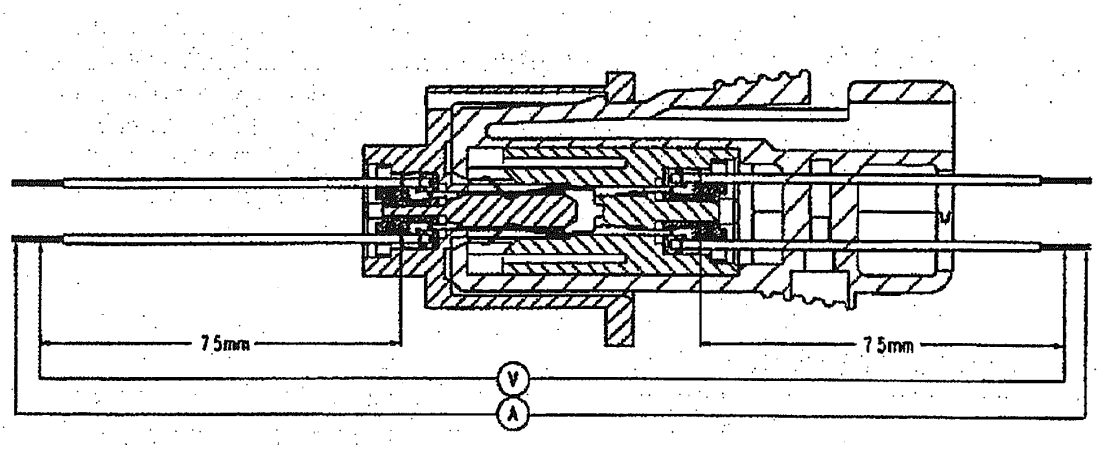


Fig. 4a: Signal Line Termination Resistance Measure Method

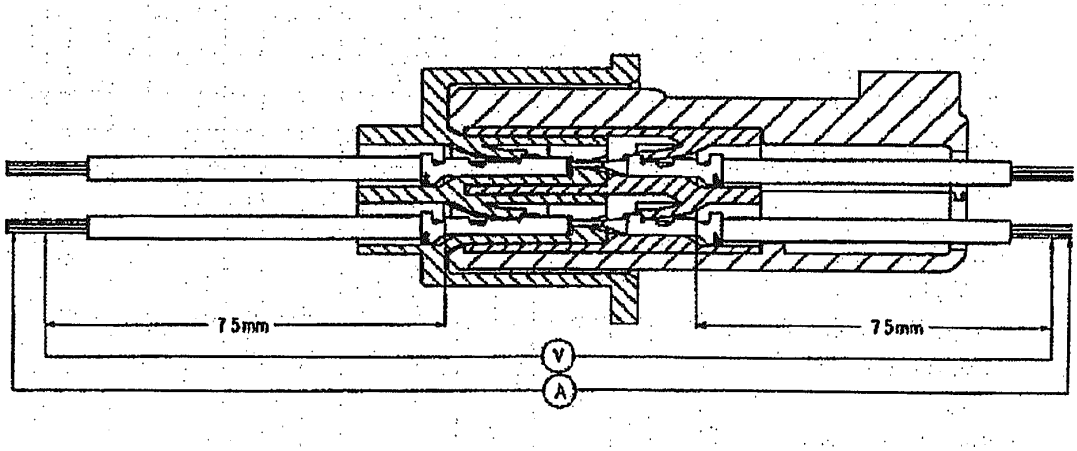


Fig. 4b: Power Line Termination Resistance Measurement Method

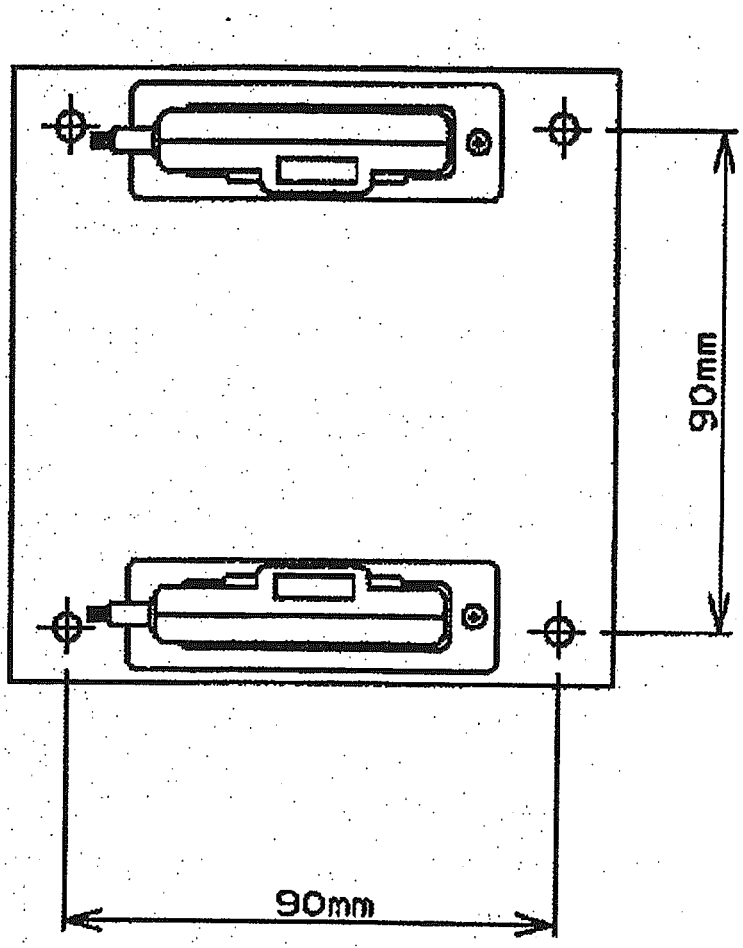


Fig. 5: Vibration Test Mounting

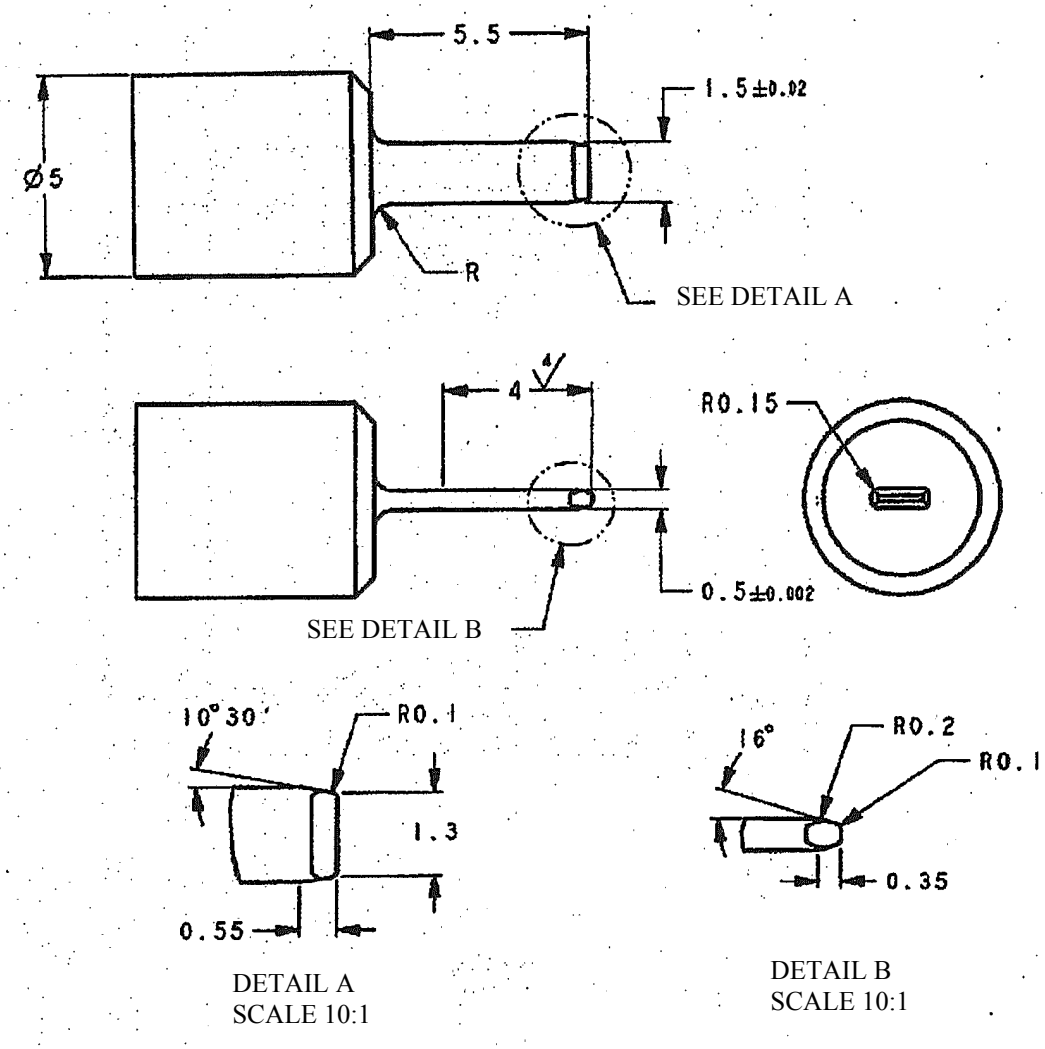
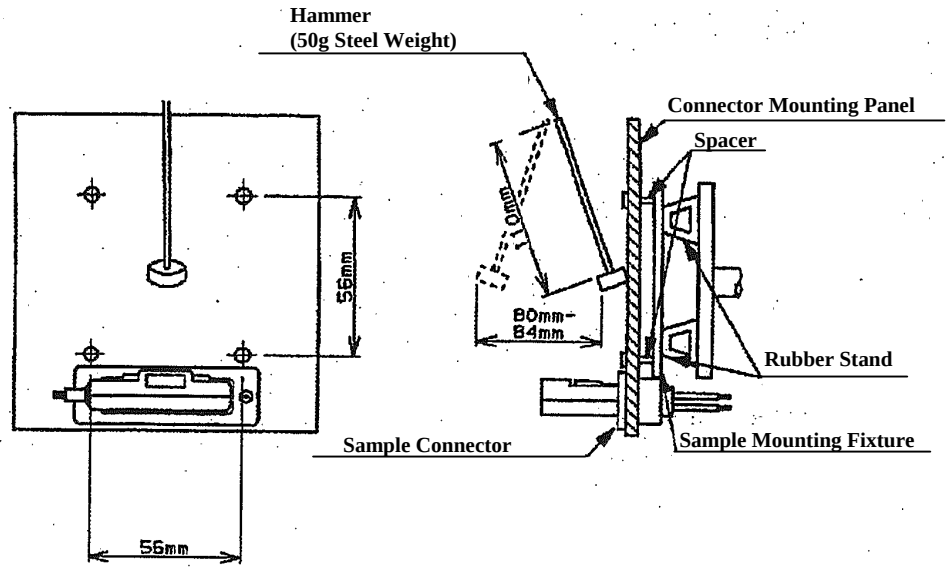


Fig. 6: Contact Mating/Unmating Force Gage



Hammer Weight Striking Frequency: 1 Strike/Second

Fig. 7: Hammering Shock Test

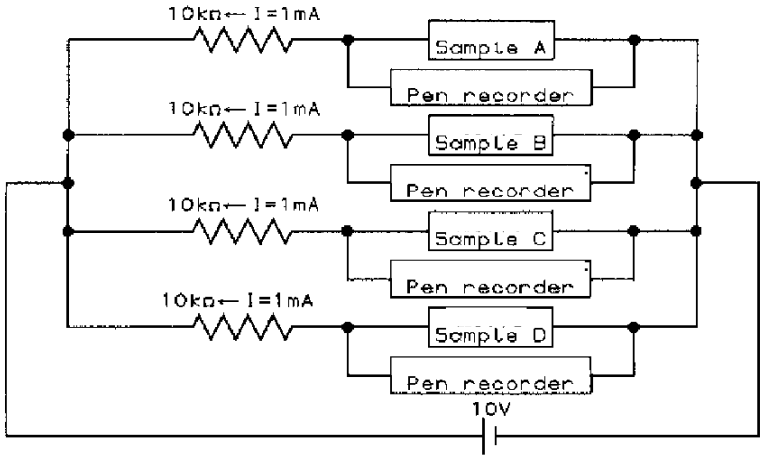


Fig. 8: Electrical Resistance Fluctuation Monitoring Circuit